

N-Channel Enhancement Mode MOSFET

TDM3750

DESCRIPTION

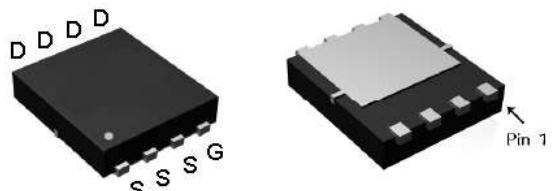
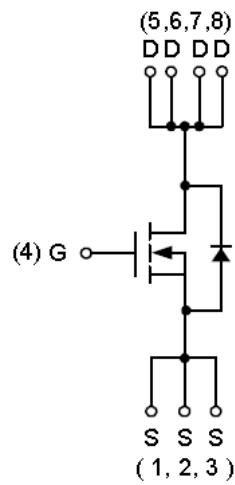
The TDM3750 uses advanced trench technology to provide excellent RDS(ON) and low gate charge. This device is suitable for use as a load switch or in PWM applications.

GENERAL FEATURES

- RDS(ON) < 7mΩ @ VGS=10V
RDS(ON) < 10mΩ @ VGS=4.5V
- High Power and current handling capability
- Lead free product is available
- Surface Mount Package

Application

- Synchronous Rectification in SMPS
- Hard Switching and High Speed Circuit
- DC/DC in Telecoms and Industrial



DFN5x6-8

ABSOLUTE MAXIMUM RATINGS($T_A=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	120	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current @ Current-Pulsed	I_{DM}	320	A
Drain Current @ Continuous(Silicon Limited)	I_D ($T_c=25^\circ\text{C}$)	99	A
	I_D ($T_c=100^\circ\text{C}$)	63	A
Drain Current @ Continuous(Package limited)	I_D ($T_c=25^\circ\text{C}$)	60	A
Maximum Power Dissipation	P_D ($T_c=25^\circ\text{C}$)	125	W
Avalanche Energy, Single Pulse	$E_{AS}(L=0.5\text{mH})$	484	mJ
Maximum Operating Junction Temperature	T_J	150	°C
Storage Temperature Range	T_{STG}	-55 To 150	°C

THERMAL CHARACTERISTICS

Thermal Resistance,Junction-to-Ambient (Note 1)	R_{JA}	50	°C/W
Thermal Resistance,Junction-to-Case	R_{JC}	1	°C/W

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ELECTRICAL CHARACTERISTICS ($T_A=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_D=250\mu\text{A}$	120	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$\text{V}_{\text{DS}}=120\text{V}, \text{V}_{\text{GS}}=0\text{V}, \text{T}_j=25^\circ\text{C}$	-	-	1	μA
Gate-Body Leakage Current	I_{GSS}	$\text{V}_{\text{GS}}=\pm 20\text{V}, \text{V}_{\text{DS}}=0\text{V}$	-	-	± 100	nA
Gate Threshold Voltage	$\text{V}_{\text{GS}(\text{th})}$	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=250\mu\text{A}$	1.4	2	2.4	V
Drain-Source On-State Resistance	$\text{R}_{\text{DS}(\text{ON})}$	$\text{V}_{\text{GS}}=10\text{V}, \text{I}_D=20\text{A}$	-	5.8	7	$\text{m}\Omega$
		$\text{V}_{\text{GS}}=4.5\text{V}, \text{I}_D=20\text{A}$	-	7.5	10	$\text{m}\Omega$
Gate Resistance	R_G	$\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}} \text{ Open}, \text{F}=1.0\text{MHz}$	-	2.6	-	Ω
Dynamic Characteristics						
Input Capacitance	C_{iss}	$\text{V}_{\text{DS}}=60\text{V}, \text{V}_{\text{GS}}=0\text{V}, \text{F}=1.0\text{MHz}$	-	3510	-	PF
Output Capacitance	C_{oss}		-	380	-	PF
Reverse Transfer Capacitance	C_{rss}		-	6.5	-	PF
Turn-on Delay Time	$\text{t}_{\text{d}(\text{on})}$	$\text{V}_{\text{DD}}=60\text{V}, \text{I}_D=20\text{A}, \text{V}_{\text{GS}}=10\text{V}, \text{R}_G=10\Omega$	-	15	-	ns
Turn-on Rise Time	t_r		-	8	-	ns
Turn-Off Delay Time	$\text{t}_{\text{d}(\text{off})}$		-	30	-	ns
Turn-Off Fall Time	t_f		-	9	-	ns
Total Gate Charge	$\text{Q}_g(10\text{V})$	$\text{V}_{\text{DD}}=60\text{V}, \text{I}_D=20\text{A}, \text{V}_{\text{GS}}=10\text{V}()$	-	45	-	nC
Total Gate Charge	$\text{Q}_g(4.5\text{V})$		-	20	-	nC
Gate-Source Charge	Q_{gs}		-	8	-	nC
Gate-Drain Charge	Q_{gd}		-	6	-	nC
Reverse Diode Characteristics						
Diode Forward Voltage	V_{SD}	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_s=20\text{A}$	-	0.9	1.2	V
Reverse Recovery Time	T_{rr}	$\text{I}_F=20\text{A}, \frac{d\text{I}}{dt}=500\text{A}/\mu\text{s}$	-	45	-	ns
Body Diode Reverse Recovery Charge	Q_{rr}		-	270	-	nC

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Typical Operating Characteristics

Fig 1. Typical Output Characteristics

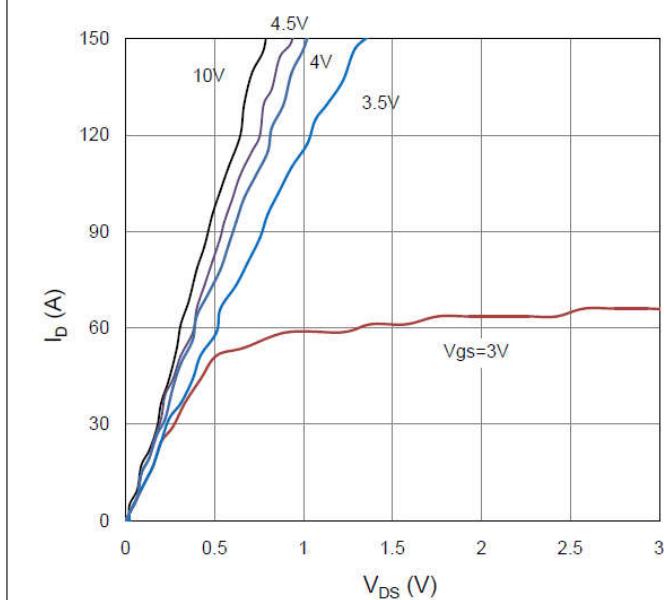


Figure 2. On-Resistance vs. Gate-Source Voltage

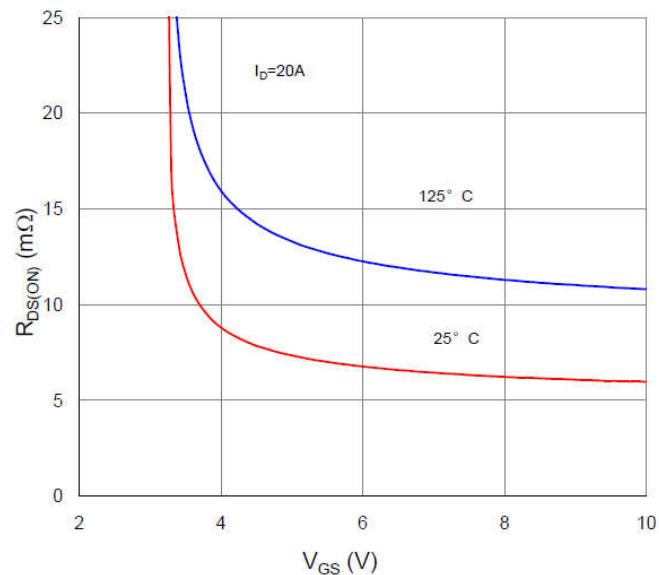


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

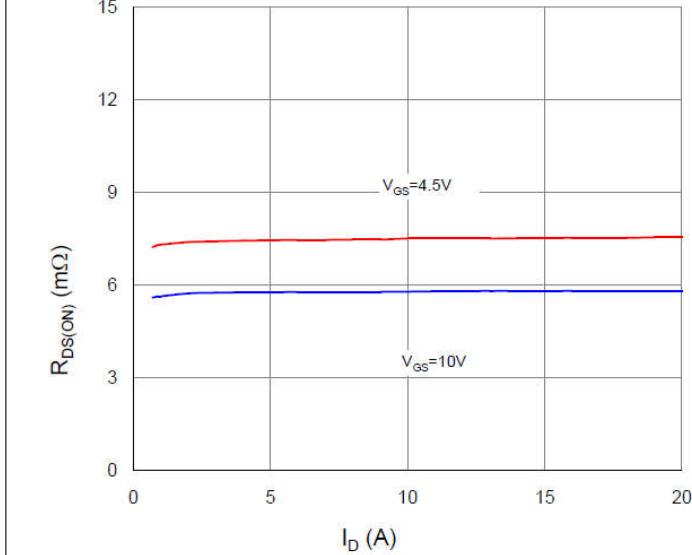
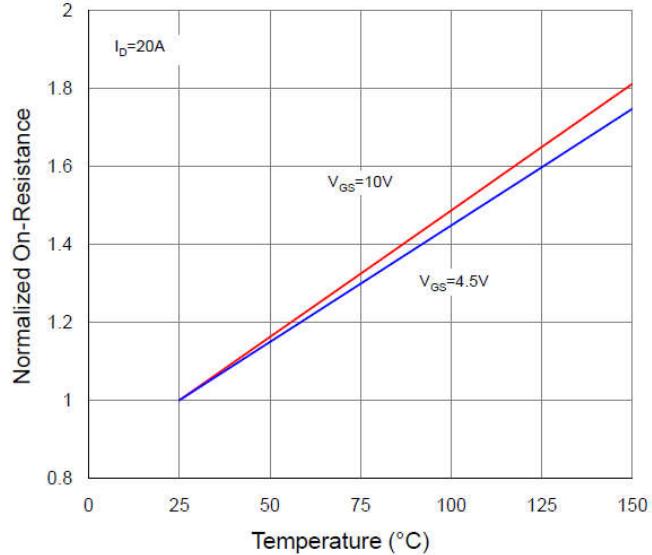


Figure 4. Normalized On-Resistance vs. Junction Temperature



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TDM3750

Typical Operating Characteristics(Cont.)

Figure 5. Typical Transfer Characteristics

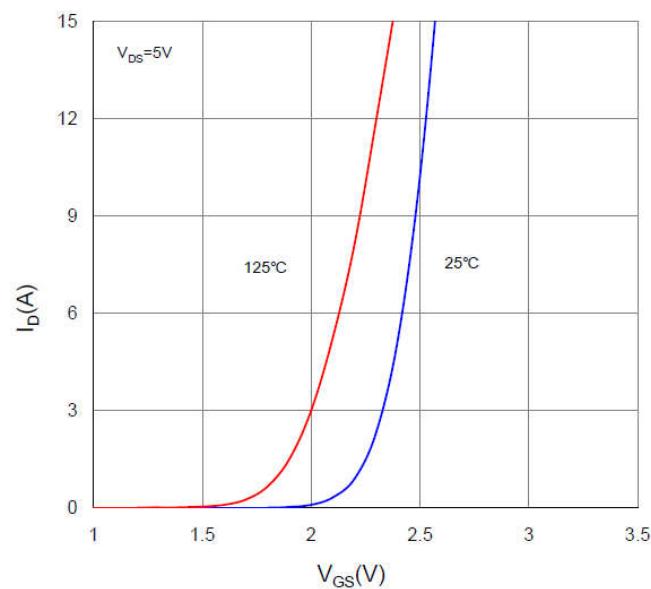


Figure 6. Typical Source-Drain Diode Forward Voltage

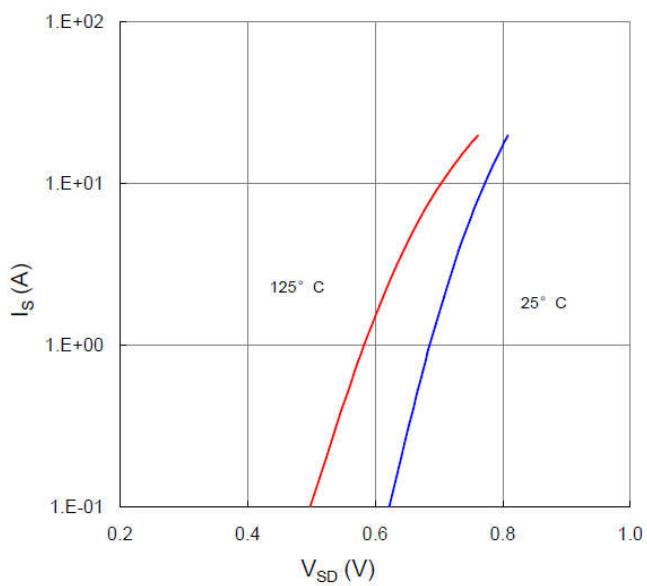


Figure 7. Typical Gate-Charge vs. Gate-to-Source Voltage

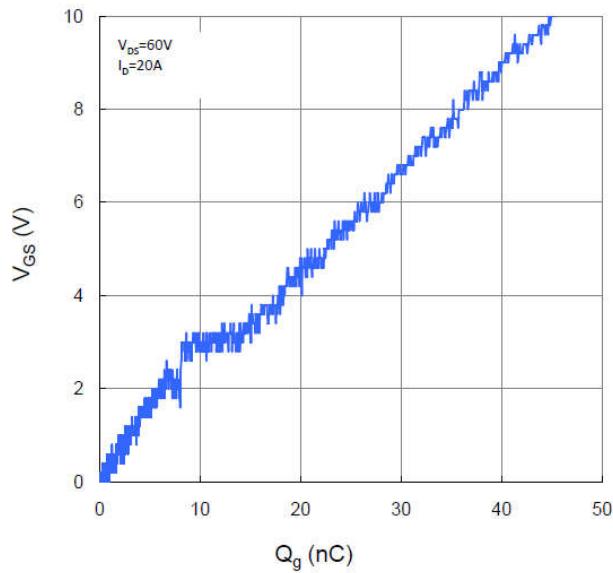
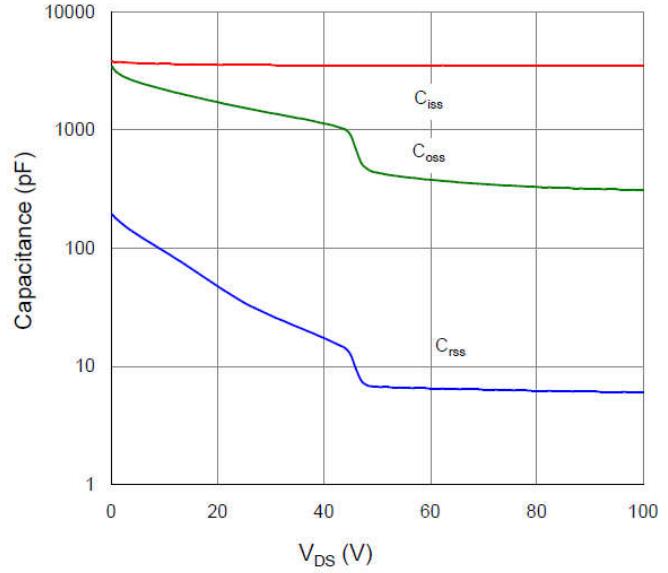


Figure 8. Typical Capacitance vs. Drain-to-Source Voltage



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TDM3750

Typical Operating Characteristics (Cont.)

Figure 9. Maximum Safe Operating Area

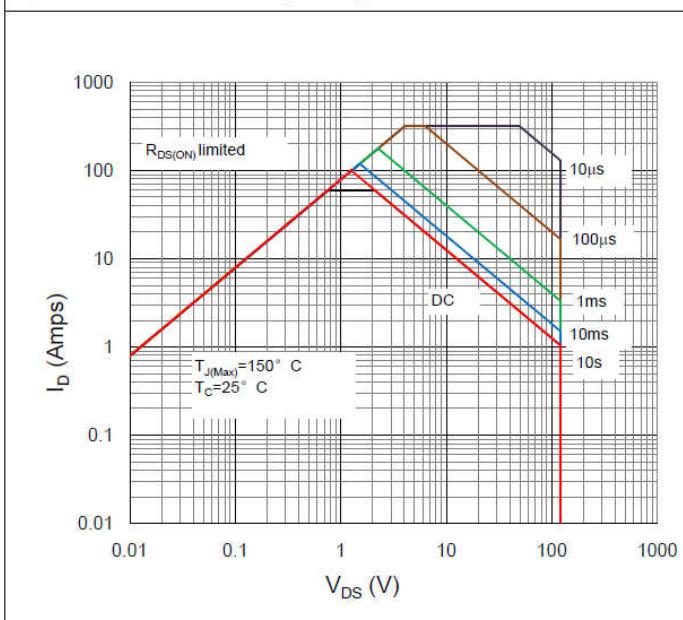


Figure 10. Maximum Drain Current vs. Case Temperature

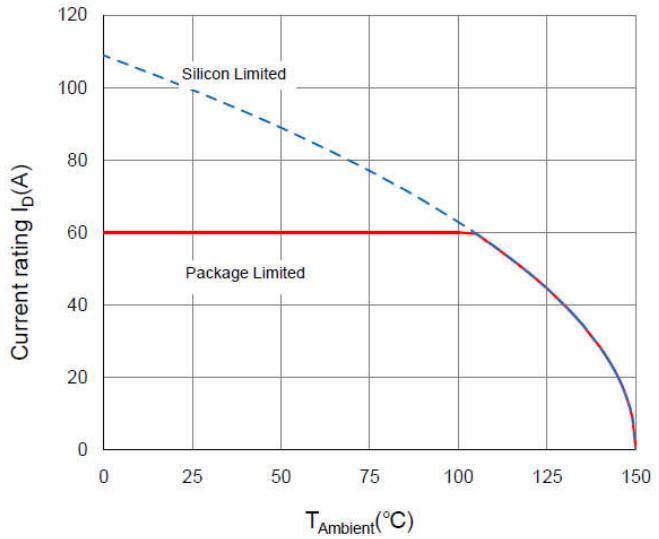
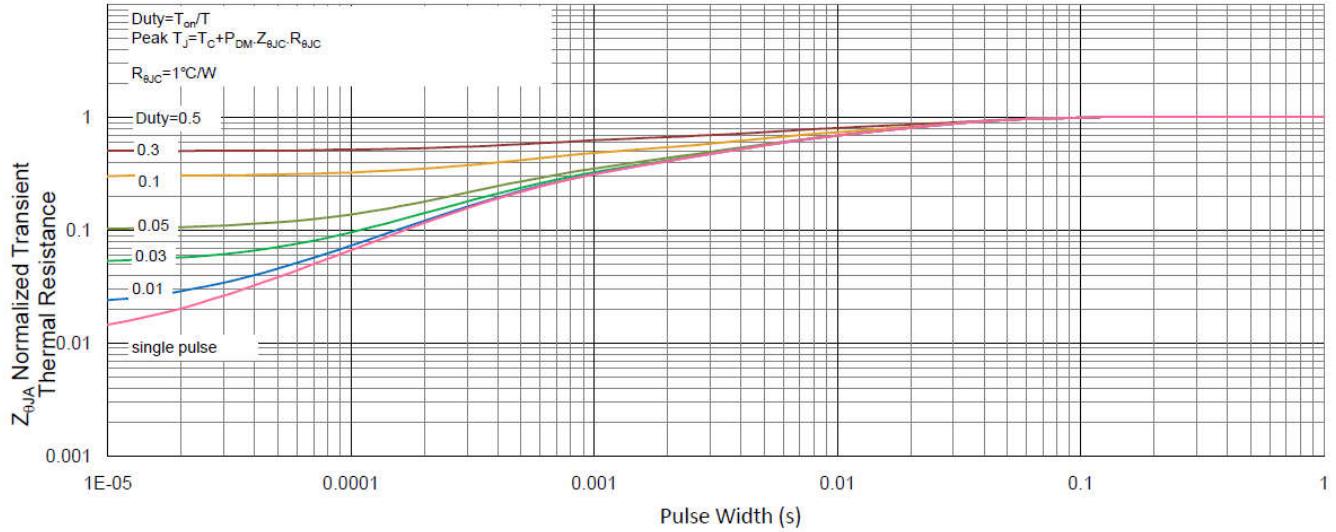


Figure 11. Normalized Maximum Transient Thermal Impedance, Junction-to-Ambient

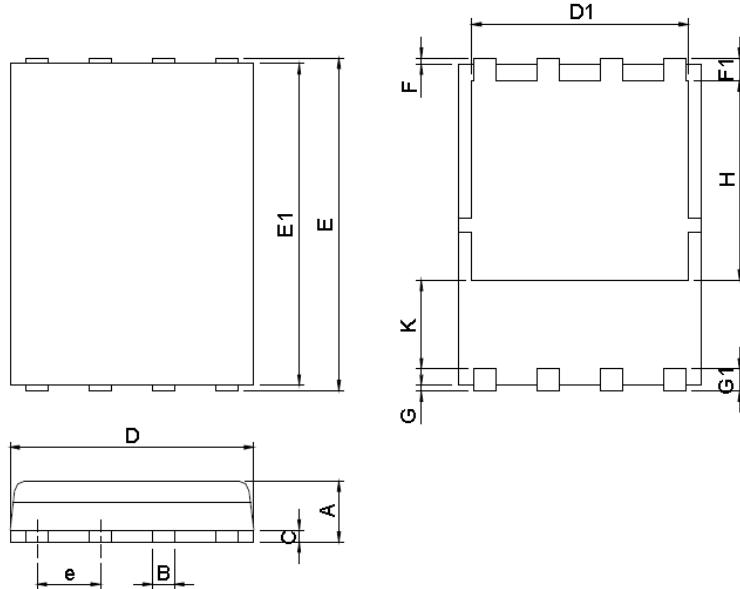


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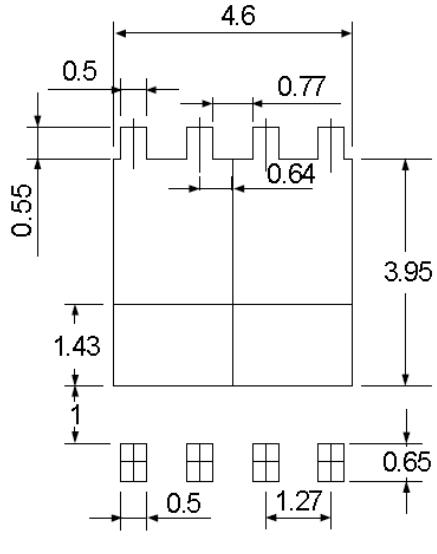
Package Information

DFN5*6-8 Package



SYMBOL	DFN5x6-8			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	0.90	1.20	0.035	0.047
B	0.3	0.51	0.012	0.020
C	0.19	0.25	0.007	0.010
D	4.80	5.30	0.189	0.209
D1	4.00	4.40	0.157	0.173
E	5.90	6.20	0.232	0.244
E1	5.50	5.80	0.217	0.228
e	1.27 BSC		0.050 BSC	
F	0.05	0.30	0.002	0.012
F1	0.35	0.75	0.014	0.030
G	0.05	0.30	0.002	0.012
G1	0.35	0.75	0.014	0.030
H	3.34	3.9	0.131	0.154
K	0.762	-	0.03	-

RECOMMENDED LAND PATTERN



UNIT: mm

Note : 1.Dimension D, D1,D2 and E1 do not include mold flash or protrusions.

Mold flash or protrusions shall not exceed 10 mil.

Design Notes